Search	earch Notes 		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/743,261	CHEN ET AL.	
Examiner	Art Unit	
Shay L. Balsis	1744	

	SEARCHED			
Class	Subclass	Date	Examiner	
15	114 117 121	7/19/2006	SB	
<u> </u>				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NO (INCLUDING SEARCH		)
	DATE	EXMR
search from Mark Spisich Class 15	7/19/2006	SB
East search (USPGPUB, USPAT, USOCR, JPO, EPO, Derwent, IBM- TBD) attached	7/20/2006	SB
inventor search done in edan	7/19/2006	SB